A High Granularity Timing Detector for the Phase-2 Upgrade of the ATLAS Calorimeter

S. Grinstein on behalf of the ATLAS LAr-HGTD group



The 11th International Conference on Position Sensitive Detectors (PSD11)

3rd - 8th September 2017



The Open University Milton Keynes (UK)



High Luminosity LHC

- LHC accelerator at CERN performing very well
- ATLAS very successful scientific output since first collisions in 2010
- To improve physics reach, the LHC accelerator machine will be upgraded
 - Foreseen for 2026, increase by 7-8 peak luminosity
- To maintain/improve physics performance, ATLAS detector will be upgraded
 - One of the main challenges of HL-LHC period will be pile-up

Phase-2, High-Luminosity LHC: 14 TeV beams Peak luminosity: 7.5E34 cm⁻²s⁻¹ (x7) Average pile-up: $\langle \mu \rangle \sim 200$ (x8) Integrated luminosity: 4000/fb (x13)





Pile-up: other pp collisions in addition to the one of interest

- Adds energy to reconstructed hard-scatter jets
- Produces pile-up jets

ATLAS and High Luminosity LHC

Current ATLAS baseline upgrade plan not optimized for pile-up mitigation at high η



- Calorimeter noise will increase significantly in HL-LHC, impairing pile-up rejection specially at high η
- **Tracking detector** (ITk) upgrade will provide excellent position resolution, but in the very forward region, resolution only reaches a few mm

Explore improvements on pile-up rejection at high η

HGTD Motivation

<u>8</u>600

400

200

0

-400

-80

-60

-40

-20

20

40

60

-200

ATLAS Preliminary

HGTD-SiW Simulation Zee event. <u> = 200

Nominal beam spot : $\sigma_7 = 45m$

- **HL-LHC** interaction region at ATLAS will have a spread with RMS of 50 mm (nominal LHC mode)
- Corresponds to ~1.6 collisions/mm for µ=200 (x6 current LHC density)
- Collisions also spread in time with RMS of 180 ps

A **High Granularity Timing Detector (HGTD)** being considered to improve the assignment of tracks to vertices in the forward region, which impacts: electron ID, jet reconstruction, missing transverse energy and b-tagging



HGTD targets a time resolution of **30 ps** to recover current LHC pile-up conditions

O:

80

100

HGTD Detector

ID PPF1

- **HGTD** would be **placed** in the forward region **between** the tracker and the end-cap calorimeter
- Tight z space: $\Delta z = 65 \text{ mm}$



HGTD Detector

• HGTD requirements of radiation hardness and compactness well met with silicon sensors



HGTD Sensor Technology

 HGTD needs to achieve about 60 ps/mip/layer resolution: technology beyond standard silicon devices

Time resolution:

$$\sigma_{\rm det}^2 = \sigma_{\rm Landau}^2 + \sigma_{\rm elec}^2$$

$$\sigma_{elec}^2 = \left(\frac{t_{rise}}{S/N}\right)^2 + \left(\left[\frac{V_{thr}}{S/t_{rise}}\right]_{RMS}\right)^2$$

Jitter

Timewalk

- Need fast and excellent S/N
 - A multiplication layer increases signal slope
 - Timewalk contribution negligible with CFD
- Thin sensors (50 μm) to reduce intrinsic Landau contribution to resolution

HGTD sensors based on thin LGAD technology

[1] G. Pellegrini et al., NIM A765 (2014) 12
 [2] H.-W. Sadrozinski et al., arXiv: 1704.08666 S. Grinstein - PSD11 2017
 [3] F. Cenna et al, NIM A796 (2015) 149-153



Low Gain Avalanche Detector (LGAD)

- Low gain (G=10-20): improve signal slope but control noise
- Developed at CNM (Barcelona) [1]
- Proposed for timing by UCSC/Torino [2]



Weightfield 2 Simulation [3]

7

HGTD Sensor Productions

- Technology development and initial productions for R&D done at CNM (Barcelona)
 - Productions in collaboration with Totem (CMS) and RD50
- Now FBK (Italy) and HPK (Japan) also producing LGAD sensors





HPK 50um LGAD diode

First* CNM production

- 4" SOI wafers
- 50 µm thickness on 300 µm support wafer
- Different implantation doses
- Various structures including:
 - Pad diodes of 1.3x1.3 mm²
 - 2x2 arrays of 2x2 and 3x3 mm² pads
 - Larger structures for different applications

First HPK production

- 6" Si-on-Si wafers
- 50 µm thickness on 150 µm support wafer
- Different implantation doses
- Various structures including:
 - Pad diodes of 0.9x0.9 mm²
 - 2x2 arrays of 3x3 mm² pads

HGTD Sensor Testing

- Laboratory measurements are carried out to characterize sensor performance
 - See, for example: G. Kramberger et al., JINST 10 (2015) P07006, J. Lange et al., JINST 12 (2917) P05003, Z. Galloway et al., arXiv:1707.04961, N. Cartiglia et al., NIM A850 (2017) 83
- But tests with particle beam provide ultimate timing measurements
 - Test-beam campaigns carried out at CERN SPS 120 GeV pion line



SiPM, LGADs, Tracking





Sensor

Multiple LGAD sensors

Also SiPM (10 ps) used for

mounted on beam

timing reference

Waveforms stored and

Landau+Gauss fits

analyzed offline (CFD)

Amplification

Oscilloscope



HGTD Sensor Performance

Results for non-irradiated LGAD sensors

- Gain determined from ratio of charge in LGAD to nongain LGAD
- Time resolution reaches **25 ps/layer** at highest gain
 - Noise mostly flat, rise time improves with voltage
 - Well within requirements, do not need to operate at very high gain
 - In agreement with other measurements
 - N. Cartiglia et al., NIM A850 (2017) 83,
 - J. Lange et al., JINST 12 (2017) P05003
- Tracking information
 - Good uniformity of signal over the pads (1%)
 - Inter pad regions remain to be optimized







HGTD Sensor Performance

Results for irradiated LGAD sensors

- Irradiated to different fluencies with neutrons (Ljubljana)
- Testbeam and laboratory measurements performed with cooling system (-6, -15, -20 °C)
- Different multiplication layer dose implants studied

Laboratory measurements with HPK irradiated samples:

- Results with Sr 90 setup
- Similar results than CNM at low fluencies
- Significant improvement at larger fluencies
 - 50ps after 6E15 neq/cm²

Testbeam results with CNM irradiated samples:

- At 3E14 neq/cm², can recover performance of unirradiated sensors (at higher V)
- At 1E15 neq/cm² about 60 ps resolution achieved
- Possible differences with HPK results being investigated (metalization, setup...)

LGAD sensors satisfy the timing resolution requirements of HGTD after irradiation

30

100

200

300

400

500

600

Voltage [V]



HGTD Electronics

- Front end electronics 1st prototype designed by **Omega** (France)
- Altiroc: Atlas Lgad Timing Integrated ReadOut Chip
- Fabricated on TSMC 130 nm technology, delivered in April 2017
- Four channels dedicated for 2pF pads (~1x1 mm² sensors)
- Also option for larger pads (10 pF and 20 pF)
- Each channel (200 μm x 100 μm) = Preamplifiers + TOT and CFD



C. de la Taille TWEPP 2017

Measured jitter ~20 ps (9.2 fC charge for 1 mip and gain=20)



- Final chip:
 - Digital output
 ToT or CFD + TDC
 - → 225 channels
 - → ~400 Mrad

• Area= 3.4 x 3.4 mm²

Thickness = 300 µm

HGTD Module

Sensor and Altrioc hybridization through bump-bonding:

- Under bump metalization of both ASIC and sensor (CNM)
 - Solder can not bond directly to aluminum
- Solder bump deposition on ASIC
 - Ball placement
- Flip-chip
 - Connection step through thermal cycle
- Reflow
- Quality control
- Module assembly
 - Gluing and wire-bonding



Signal of Sr90 source verified Will be tested with beam in Sept.







Conclusions

- HGTD detector promises to improve pile-up rejection for HL-LHC
 - Significant improvements on reconstruction performance at high- η
- Proposed LGAD sensor technology
 - Well suited to meet HGTD requirements
 - Timing, occupancy, physical space and radiation hardness
 - Challenging <30 ps resolution obtained for diodes before irradiation
 - Good **uniformity** of response within pad diode observed (<1%)
 - Irradiated LGAD sensors satisfy HGTD radiation hardness requirement
- First version of dedicated **ASIC** fabricated
 - Initial module prototypes assembled, preliminary tests successful

Backup Slides